Notice of References Cited Application/Control No. 10/789,666 Examiner Jeremy Bukowczyk Applicant(s)/Patent Under Reexamination FONG ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0193420 a1	09-2004	Kennewick et al.	704/257
*	В	US-2002/0165667 a1	11-2002	Lee, Eun-Hee	701/211
*	C	US-2003/0145338 a1	07-2003	Harrington, Jeffrey M.	725/136
*	D	US-2002/0020750 a1	02-2002	Dymetman et al.	235/472.01
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	1	US-			
	7	US-			
	К	US-			
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q	·				
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.